Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/784,716	ISHIHARA ET AL	
Examiner	Art Unit	
John O. Nauven	2654	

SEARCHED					
Class	Subclass	Date	Examiner		
242	338.1 343 348 348.2	9/28/2005	JN		
360	132	9/28/2005	JN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
	;				
		·			